Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,276	OLSCHEWSKI, FRANK	
Examiner	Art Unit	
Charles Kim	2624	

Charles Kim

SEARCHED				
Subclass	Date	Examiner		
	Subclass	Subclass Date		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
search updated (see search history report)	8/13/2007	СК
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